

High-speed diode

BAV10**FEATURES**

- Hermetically sealed leaded glass SOD27 (DO-35) package
- High switching speed: max. 6 ns
- General application
- Continuous reverse voltage: max. 60 V
- Repetitive peak reverse voltage: max. 60 V
- Repetitive peak forward current: max. 600 mA.

DESCRIPTION

The BAV10 is a high-speed switching diode fabricated in planar technology, and encapsulated in the hermetically sealed leaded glass SOD27 (DO-35) package.



MAM246

The diode is type branded.

Fig.1 Simplified outline (SOD27; DO-35) and symbol.

APPLICATIONS

- High-speed switching.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{RRM}	repetitive peak reverse voltage		—	60	V
V_R	continuous reverse voltage		—	60	V
I_F	continuous forward current	see Fig.2; note 1	—	300	mA
I_{FRM}	repetitive peak forward current		—	600	mA
I_{FSM}	non-repetitive peak forward current	square wave; $T_j = 25^\circ\text{C}$ prior to surge; see Fig.4 $t = 1 \mu\text{s}$ $t = 100 \mu\text{s}$ $t = 1 \text{ s}$	— — —	9 3 1	A
P_{tot}	total power dissipation	$T_{\text{amb}} = 25^\circ\text{C}$; note 1	—	350	mW
T_{stg}	storage temperature		-65	+200	°C
T_j	junction temperature		—	200	°C

Note

1. Device mounted on an FR4 printed circuit-board; lead length 10 mm.

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ELECTRICAL CHARACTERISTICS

 $T_j = 25^\circ\text{C}$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_F	forward voltage	see Fig.3 $I_F = 10 \text{ mA}$ $I_F = 200 \text{ mA}$ $I_F = 500 \text{ mA}$ $I_F = 200 \text{ mA}; T_j = 100^\circ\text{C}$	—	750 1.0 1.25 950	mV V V mV
I_R	reverse current	see Fig.5 $V_R = 60 \text{ V}$ $V_R = 60 \text{ V}; T_j = 150^\circ\text{C}$	—	100 100	nA μA
C_d	diode capacitance	$f = 1 \text{ MHz}; V_R = 0$; see Fig.6	—	2.5	pF
t_{rr}	reverse recovery time	when switched from $I_F = 400 \text{ mA}$ to $I_R = 400 \text{ mA}; R_L = 100 \Omega$; measured at $I_R = 40 \text{ mA}$; see Fig.7	—	6	ns
V_{fr}	forward recovery voltage	when switched from $I_F = 400 \text{ mA}$; $t_r = 30 \text{ ns}$; see Fig.8	—	2	V
		when switched from $I_F = 400 \text{ mA}$; $t_r = 10 \text{ ns}$; see Fig.8	—	1.5	V

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th,j-tp}$	thermal resistance from junction to tie-point	lead length 10 mm	240	K/W
$R_{th,j-a}$	thermal resistance from junction to ambient	lead length 10 mm; note 1	500	K/W

Note

1. Device mounted on a printed circuit-board without metallization pad.

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GRAPHICAL DATA

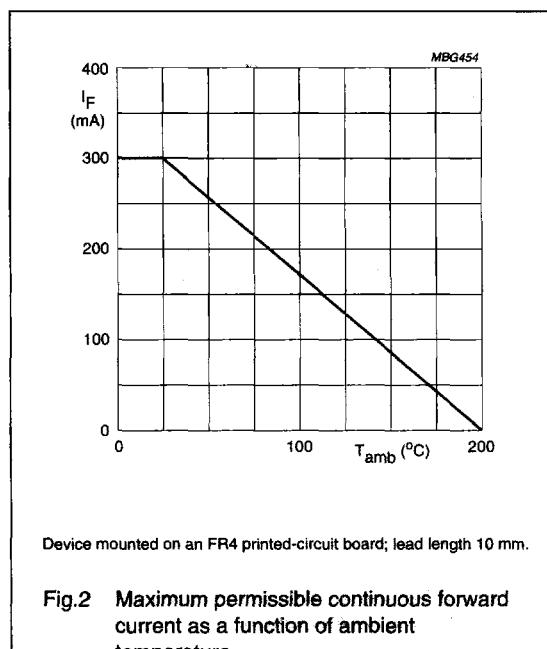


Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.

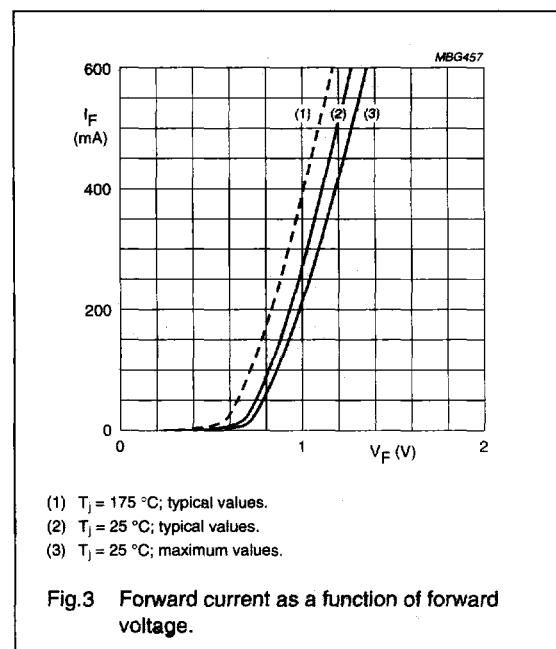


Fig.3 Forward current as a function of forward voltage.

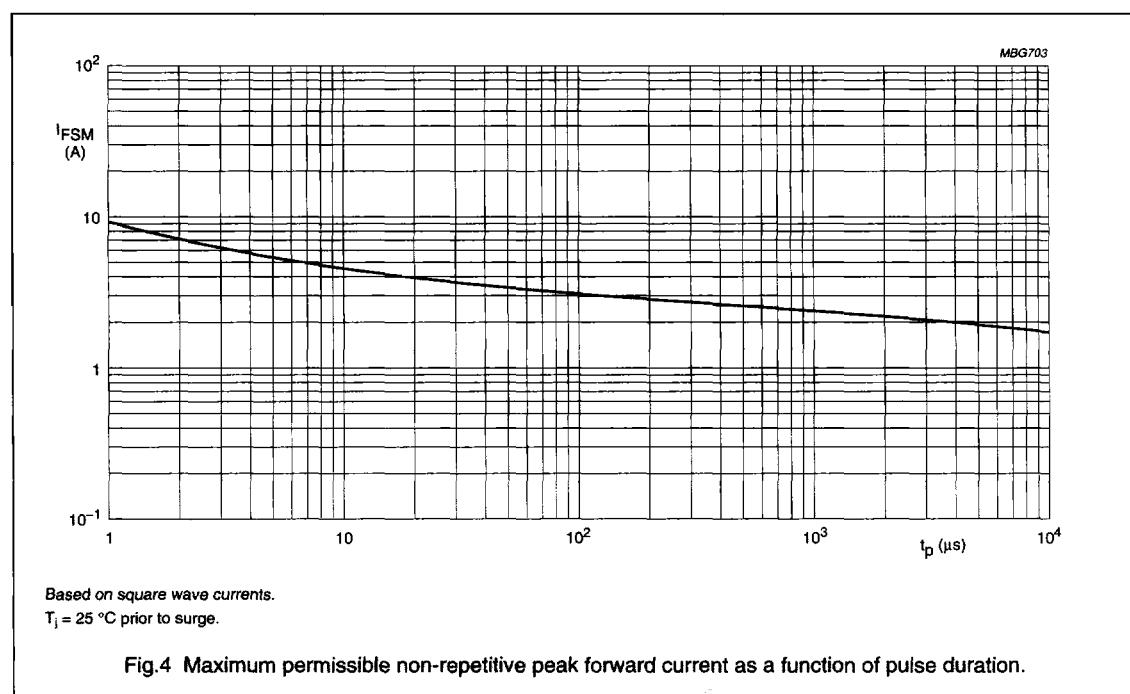
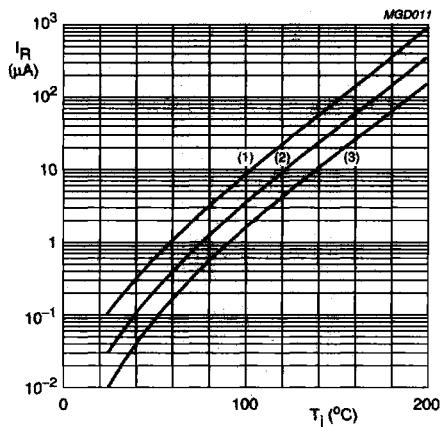
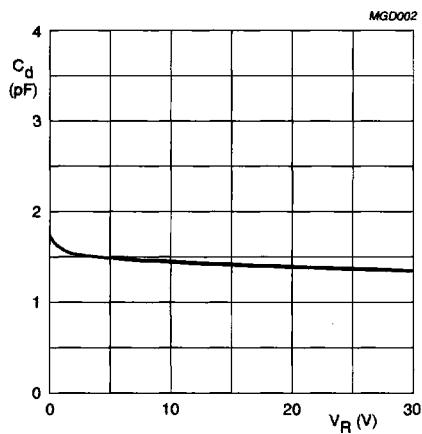


Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

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- (1) $V_R = 60$ V; maximum values.
- (2) $V_R = 60$ V; typical values.
- (3) $V_R = 30$ V; typical values.

Fig.5 Reverse current as a function of junction temperature.



$f = 1$ MHz; $T_J = 25$ $^\circ\text{C}$.

Fig.6 Diode capacitance as a function of reverse voltage; typical values.

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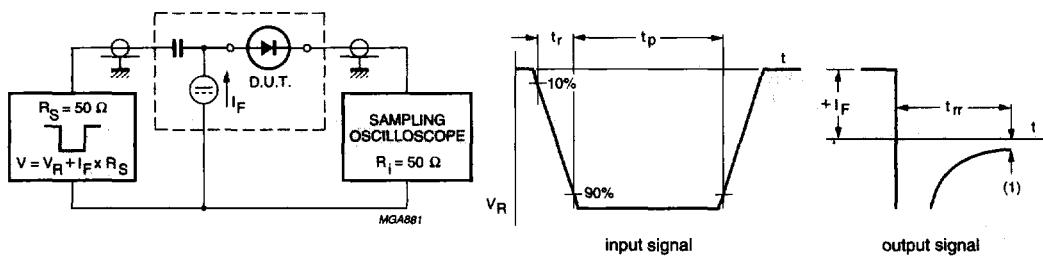
(1) $I_R = 40 \text{ mA}.$

Fig.7 Reverse recovery voltage test circuit and waveforms.

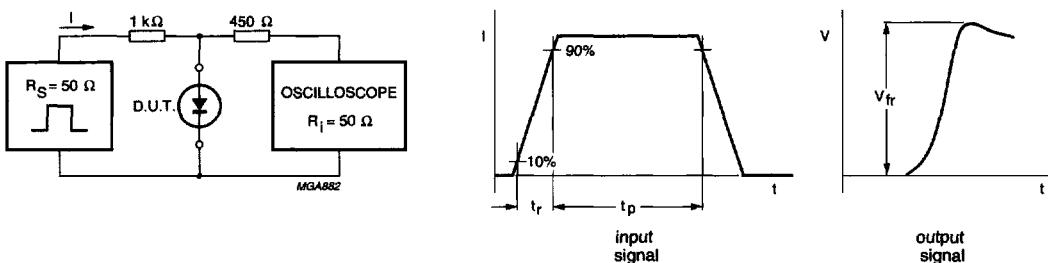
Input signal: forward pulse duration $t_p = 300 \text{ ns}$; duty factor $\delta = 0.01$.

Fig.8 Forward recovery voltage test circuit and waveforms.